

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TAN ET AL.	
		Examiner Jacob Cheu	Art Unit 1641	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,795,734	08-1998	Flanagan et al.	435/69.1
*	B	US-2003/0108869	06-2003	Michnick et al.	435/6
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	T	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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